

NTTS2P02R2

Power MOSFET -2.4 Amps, -20 Volts

Single P-Channel Micro8™

Features

- Ultra Low $R_{DS(on)}$
- Higher Efficiency Extending Battery Life
- Logic Level Gate Drive
- Miniature Micro-8 Surface Mount Package
- Diode Exhibits High Speed, Soft Recovery
- Micro8 Mounting Information Provided
- Pb-Free Package is Available

Applications

- Power Management in Portable and Battery-Powered Products, i.e.: Cellular and Cordless Telephones, and PCMCIA Cards

MAXIMUM RATINGS ($T_J = 25^\circ\text{C}$ unless otherwise noted)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V_{DSS}	-20	V
Gate-to-Source Voltage – Continuous	V_{GS}	± 8.0	V
Thermal Resistance – Junction-to-Ambient (Note 1) Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 70^\circ\text{C}$ Pulsed Drain Current (Note 3)	$R_{\theta JA}$ P_D I_D I_D I_{DM}	160 0.78 -2.4 -1.92 -20	$^\circ\text{C/W}$ W A A A
Thermal Resistance – Junction-to-Ambient (Note 2) Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 25^\circ\text{C}$ Continuous Drain Current @ $T_A = 70^\circ\text{C}$ Pulsed Drain Current (Note 3)	$R_{\theta JA}$ P_D I_D I_D I_{DM}	88 1.42 -3.25 -2.6 -30	$^\circ\text{C/W}$ W A A A
Operating and Storage Temperature Range	T_J, T_{stg}	-55 to +150	$^\circ\text{C}$
Single Pulse Drain-to-Source Avalanche Energy – Starting $T_J = 25^\circ\text{C}$ ($V_{DD} = -20\text{ Vdc}$, $V_{GS} = -4.5\text{ Vdc}$, Peak $I_L = -5.0\text{ Apk}$, $L = 28\text{ mH}$, $R_G = 25\ \Omega$)	EAS	350	mJ
Maximum Lead Temperature for Soldering Purposes for 10 seconds	T_L	260	$^\circ\text{C}$

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Minimum FR-4 or G-10 PCB, Steady State.
2. Mounted onto a 2" square FR-4 Board
(1 IN SQ, 2 oz Cu 0.06" thick single sided), Steady State.
3. Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2\%$.



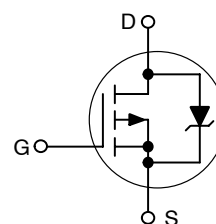
ON Semiconductor®

<http://onsemi.com>

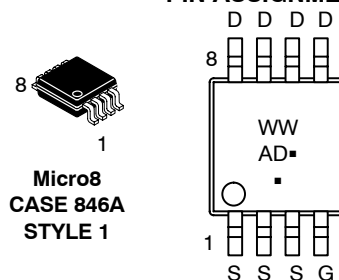
**-2.4 AMPERES
-20 VOLTS**

$R_{DS(on)} = 90\text{ m}\Omega$

Single P-Channel



MARKING DIAGRAM &
PIN ASSIGNMENT



AD = Specific Device Code

WW = Work Week

■ = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping†
NTTS2P02R2	Micro8	4000/Tape & Reel
NTTS2P02R2G	Micro8 (Pb-Free)	4000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

NTTS2P02R2

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted) (Note 4)

Characteristic	Symbol	Min	Typ	Max	Unit
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OFF CHARACTERISTICS

Drain-to-Source Breakdown Voltage (V _{GS} = 0 Vdc, I _D = -250 μAdc) Temperature Coefficient (Positive)	V _{(BR)DSS}	-20 -	- -12.7	- -	Vdc mV/°C
Zero Gate Voltage Drain Current (V _{GS} = 0 Vdc, V _{DS} = -16 Vdc, T _J = 25°C) (V _{GS} = 0 Vdc, V _{DS} = -16 Vdc, T _J = 125°C)	I _{DSS}	- -	- -	-1.0 -25	μAdc
Zero Gate Voltage Drain Current (V _{GS} = 0 Vdc, V _{DS} = -20 Vdc, T _J = 25°C)	I _{DSS}	-	-	-5.0	μAdc
Gate-Body Leakage Current (V _{GS} = -8 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	-	-100	nAdc
Gate-Body Leakage Current (V _{GS} = +8 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	-	-	100	nAdc

ON CHARACTERISTICS

Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = -250 μAdc) Temperature Coefficient (Negative)	V _{GS(th)}	-0.5 -	-0.90 2.5	-1.4 -	Vdc mV/°C
Static Drain-to-Source On-State Resistance (V _{GS} = -4.5 Vdc, I _D = -2.4 Adc) (V _{GS} = -2.7 Vdc, I _D = -1.2 Adc) (V _{GS} = -2.5 Vdc, I _D = -1.2 Adc)	R _{DS(on)}	- - -	0.070 0.100 0.110	0.090 0.130 -	Ω
Forward Transconductance (V _{DS} = -10 Vdc, I _D = -1.2 Adc)	g _{FS}	2.0	4.2	-	Mhos

DYNAMIC CHARACTERISTICS

Input Capacitance	(V _{DS} = -16 Vdc, V _{GS} = 0 Vdc, f = 1.0 MHz)	C _{iss}	-	550	-	pF
Output Capacitance		C _{oss}	-	200	-	
Reverse Transfer Capacitance		C _{rss}	-	100	-	

SWITCHING CHARACTERISTICS (Notes 5 & 6)

Turn-On Delay Time	(V _{DD} = -10 Vdc, I _D = -2.4 Adc, V _{GS} = -4.5 Vdc, R _G = 6.0 Ω)	t _{d(on)}	-	10	-	ns
Rise Time		t _r	-	31	-	
Turn-Off Delay Time		t _{d(off)}	-	33	-	
Fall Time		t _f	-	29	-	
Turn-On Delay Time	(V _{DD} = -10 Vdc, I _D = -1.2 Adc, V _{GS} = -2.7 Vdc, R _G = 6.0 Ω)	t _{d(on)}	-	15	-	ns
Rise Time		t _r	-	40	-	
Turn-Off Delay Time		t _{d(off)}	-	35	-	
Fall Time		t _f	-	35	-	
Total Gate Charge	(V _{DS} = -16 Vdc, V _{GS} = -4.5 Vdc, I _D = -2.4 Adc)	Q _{tot}	-	10	18	nC
Gate-Source Charge		Q _{gs}	-	1.5	-	
Gate-Drain Charge		Q _{gd}	-	5.0	-	

BODY-DRAIN DIODE RATINGS (Note 5)

Diode Forward On-Voltage	(I _S = -2.4 Adc, V _{GS} = 0 Vdc) (I _S = -2.4 Adc, V _{GS} = 0 Vdc, T _J = 125°C)	V _{SD}	- -	-0.88 -0.75	-1.0 -	Vdc
Reverse Recovery Time	(I _S = -2.4 Adc, V _{GS} = 0 Vdc, dI _S /dt = 100 A/μs)	t _{rr}	-	37	-	ns
		t _a	-	16	-	
		t _b	-	21	-	
Reverse Recovery Stored Charge		Q _{RR}	-	0.025	-	μC

4. Handling precautions to protect against electrostatic discharge are mandatory.

5. Indicates Pulse Test: Pulse Width = 300 μs max, Duty Cycle = 2%.

6. Switching characteristics are independent of operating junction temperature.

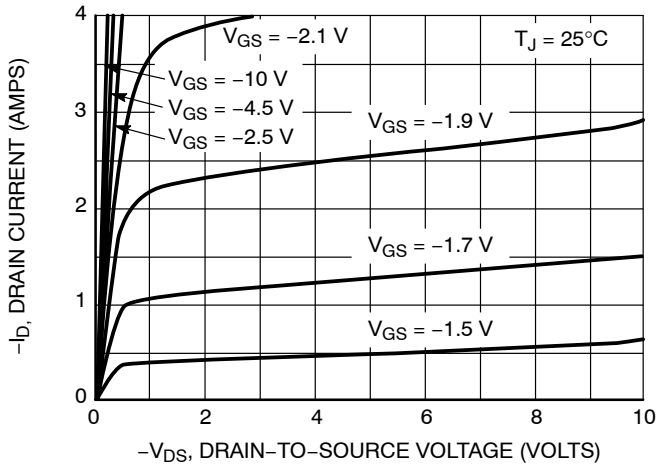


Figure 1. On-Region Characteristics.

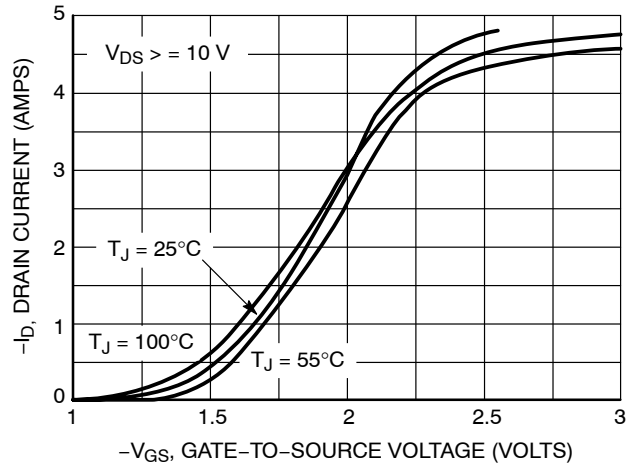


Figure 2. Transfer Characteristics.

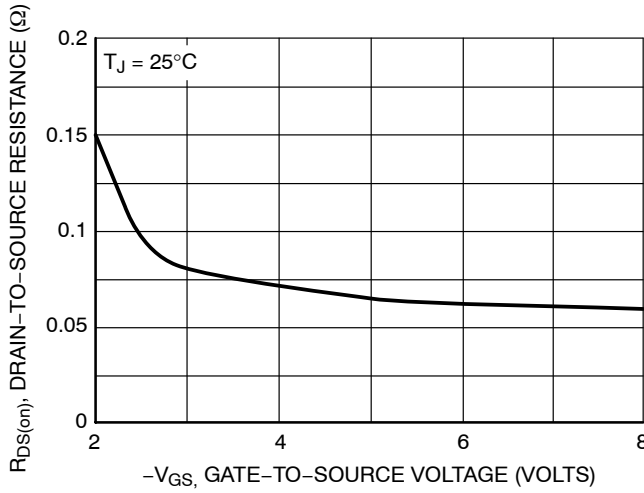


Figure 3. On-Resistance vs. Gate-to-Source Voltage.

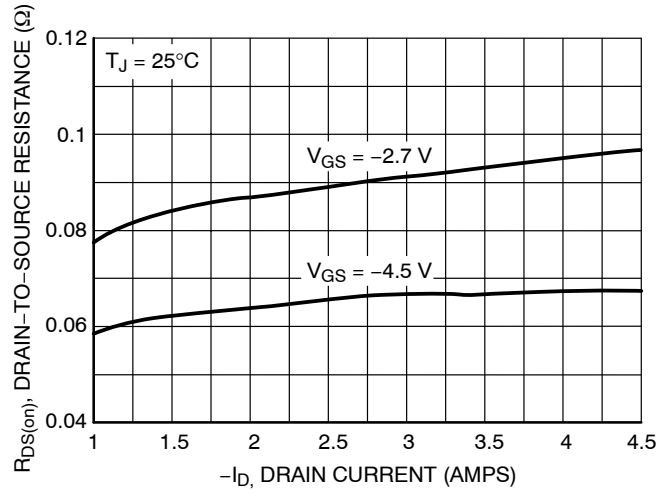


Figure 4. On-Resistance vs. Drain Current and Gate Voltage.

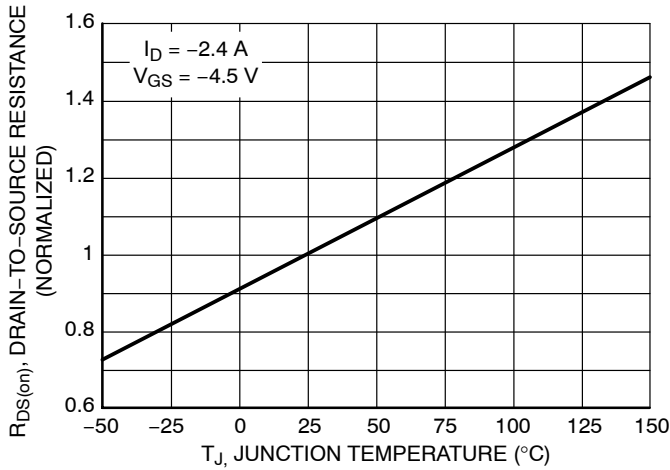


Figure 5. On-Resistance Variation with Temperature.

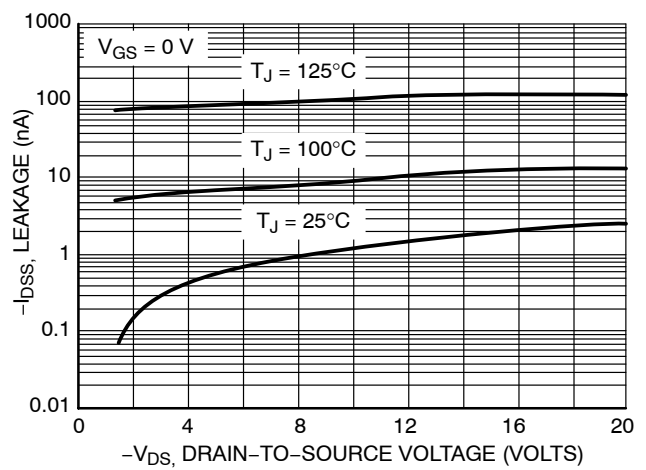


Figure 6. Drain-to-Source Leakage Current vs. Voltage.

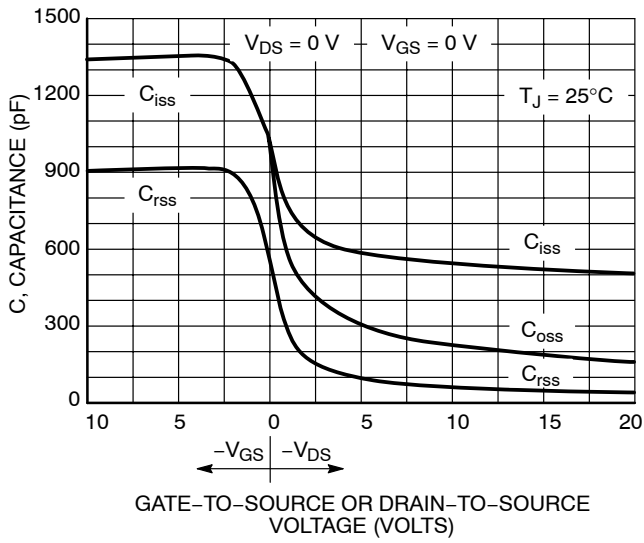


Figure 7. Capacitance Variation

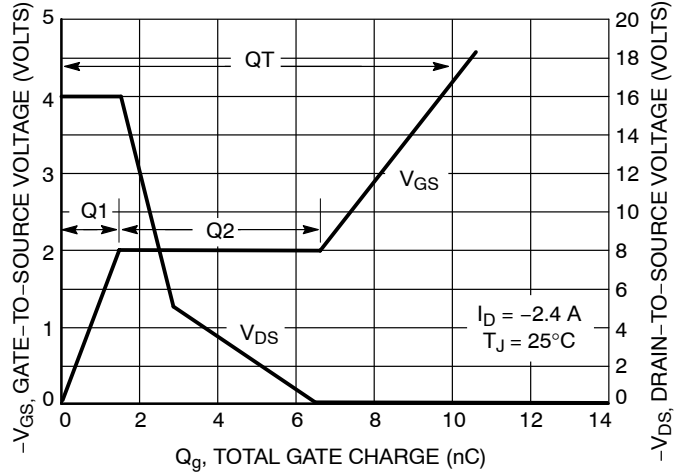


Figure 8. Gate-to-Source and Drain-to-Source Voltage versus Total Charge

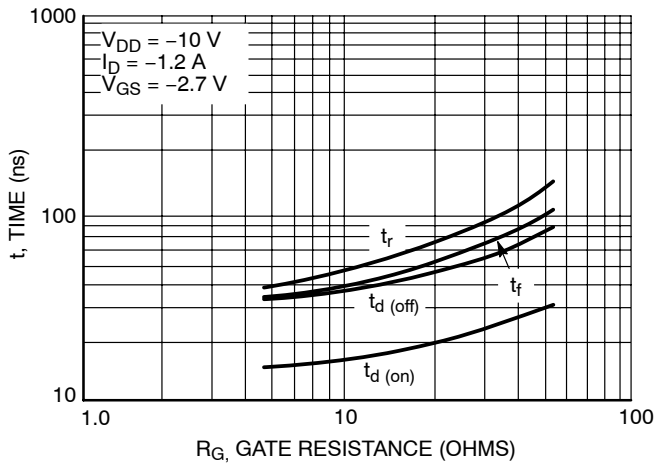


Figure 9. Resistive Switching Time Variation versus Gate Resistance

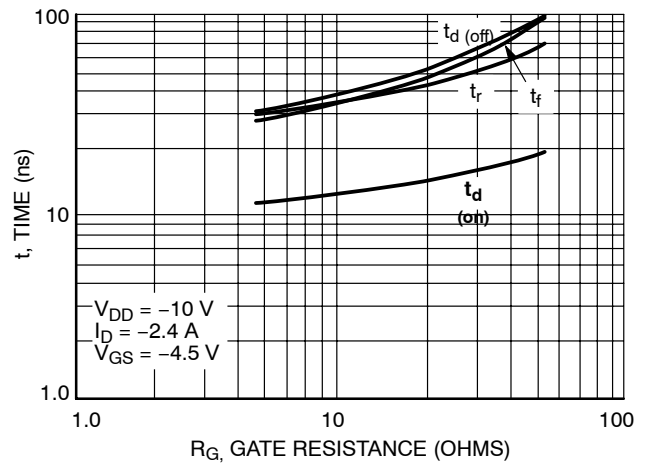


Figure 10. Resistive Switching Time Variation versus Gate Resistance

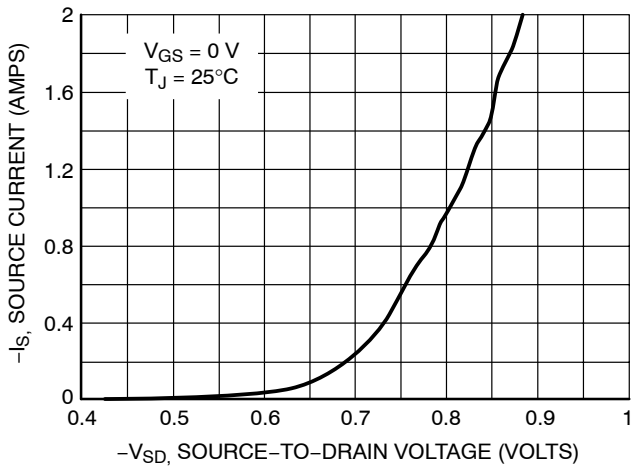


Figure 11. Diode Forward Voltage versus Current

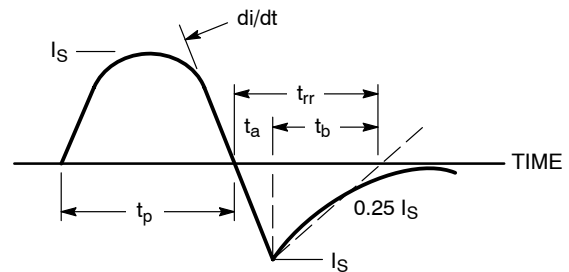


Figure 12. Diode Reverse Recovery Waveform

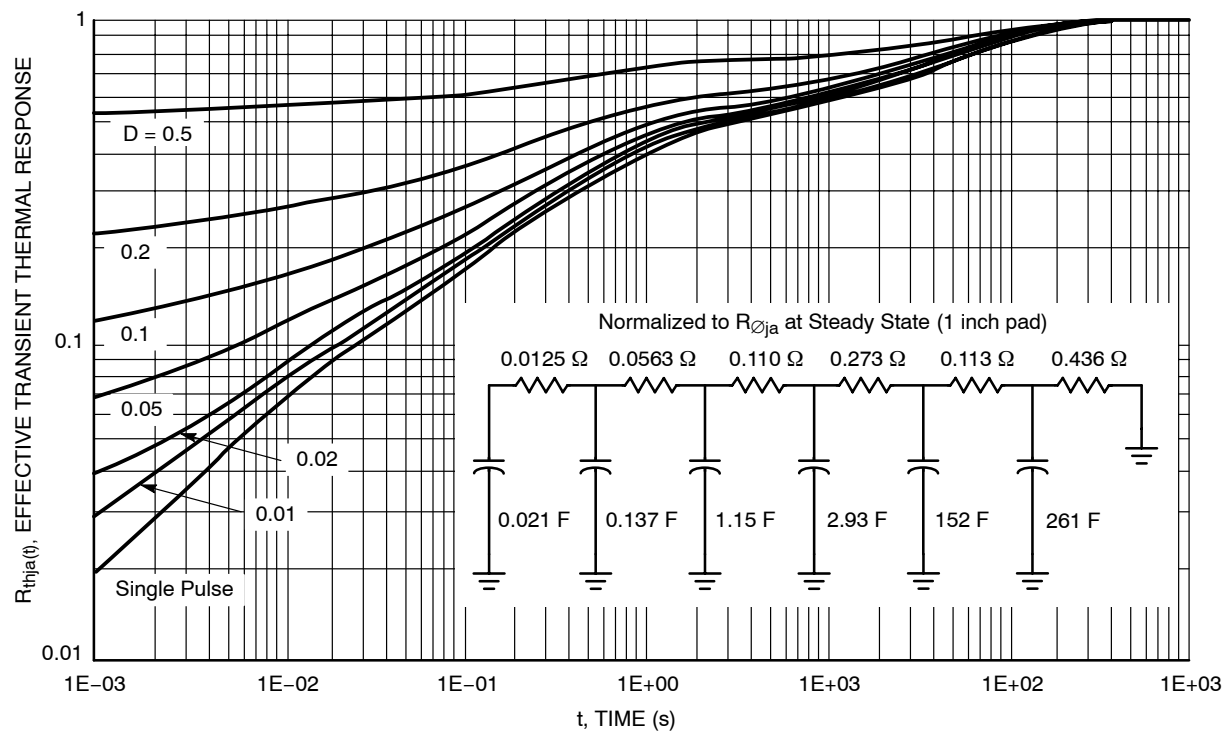
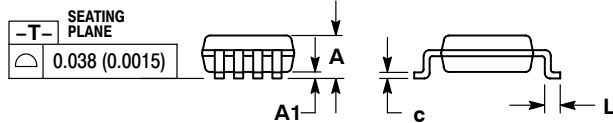
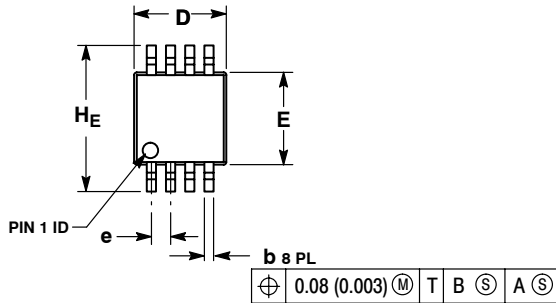


Figure 13. FET Thermal Response.

NTTS2P02R2

PACKAGE DIMENSIONS

Micro8™ CASE 846A-02 ISSUE G



NOTES:

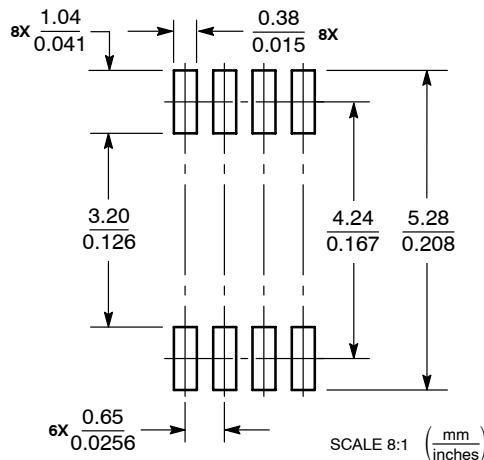
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. 846A-01 OBSOLETE, NEW STANDARD 846A-02.

DIM	MILLIMETERS			INCHES		
	MIN	NOM	MAX	MIN	NOM	MAX
A	--	--	1.10	--	--	0.043
A1	0.05	0.08	0.15	0.002	0.003	0.006
b	0.25	0.33	0.40	0.010	0.013	0.016
c	0.13	0.18	0.23	0.005	0.007	0.009
D	2.90	3.00	3.10	0.114	0.118	0.122
E	2.90	3.00	3.10	0.114	0.118	0.122
e	0.65 BSC			0.026 BSC		
L	0.40	0.55	0.70	0.016	0.021	0.028
HE	4.75	4.90	5.05	0.187	0.193	0.199

STYLE 2:

- PIN 1. SOURCE 1
- GATE 1
- SOURCE 2
- GATE 2
- DRAIN 2
- DRAIN 2
- DRAIN 1
- DRAIN 1

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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